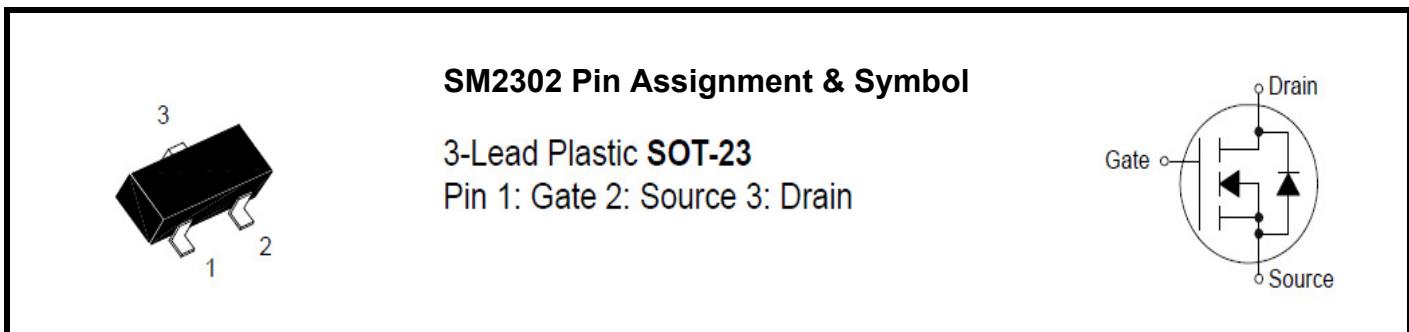


N-Channel Enhancement-Mode MOSFET(20V, 2.8A)


PRODUCT SUMMARY		
V _{DSS}	I _D	R _{D(on)} (m-ohm) Max
20V	2.8A	60 @ VGS = 4.5V, ID=2.8A
		115 @ VGS = 2.5V, ID=2.0A
		130 @ VGS = 1.8V, ID=2.0A

◆ Features

1. Advanced Trench Process Technology.
2. High Density Cell Design for Ultra Low On-Resistance.
3. Fully Characterized Avalanche Voltage and Current.
4. Improved Shoot-Through FOM.
5. RoHS Compliant.



◆ Ordering Information

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
SM2302SRL	SM2302SRG	SOT-23	G	S	D	Tape Reel
SM2302LR L	SM2302LR G	SOT-23-3L	G	S	D	Tape Reel
SM2302X X X			(1) S: SOT-23; L: SOT-23-3L (2) R: Tape Reel (3) G: Halogen Free; L: Lead Free			
(1) Package Type (2) Packing Type (3) Lead Free						

◆ Absolute Maximum Ratings ($T_A=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 8	V
I_D	Drain Current (Continuous) ^a	2.8	A
I_{DM}	Drain Current (Pulsed) ^b	8	A
P_D	Total Power Dissipation @ $T_A=25^\circ\text{C}$	0.9	W
T_j, T_{stg}	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (PCB mounted) ^c	140	$^\circ\text{C}/\text{W}$

a:Fused current that based on wire numbers and diameter

b:Repetitive Rating: Pulse width limited by the maximum junction temperature

c:1-in² 2oz Cu PCB board

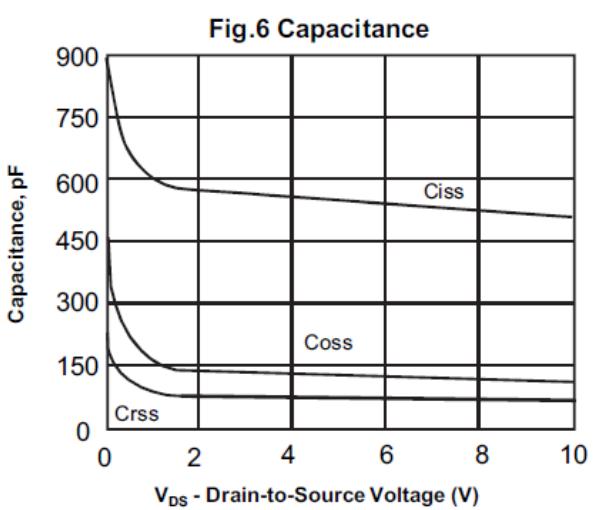
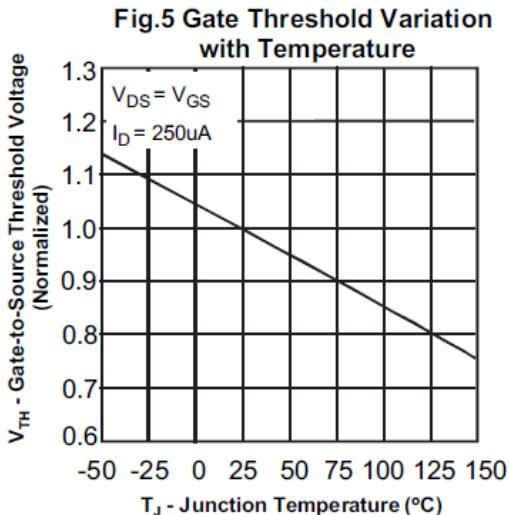
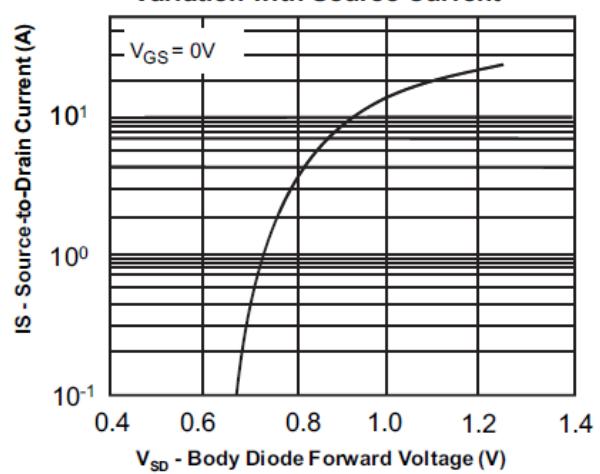
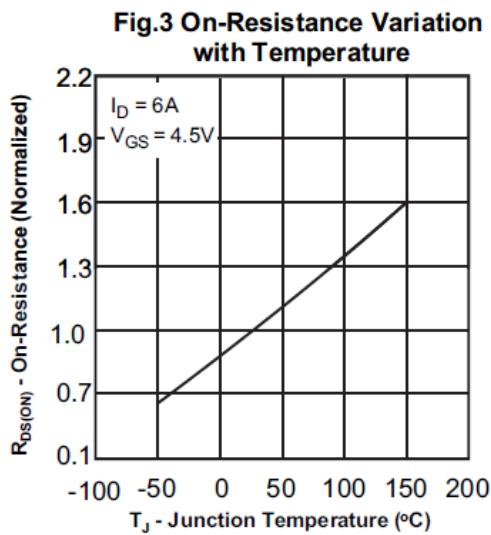
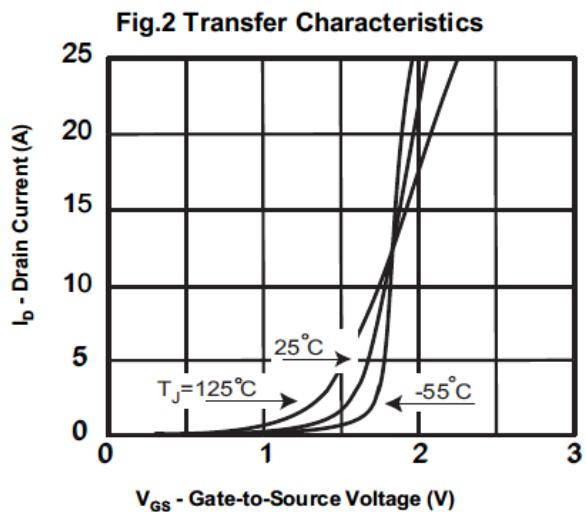
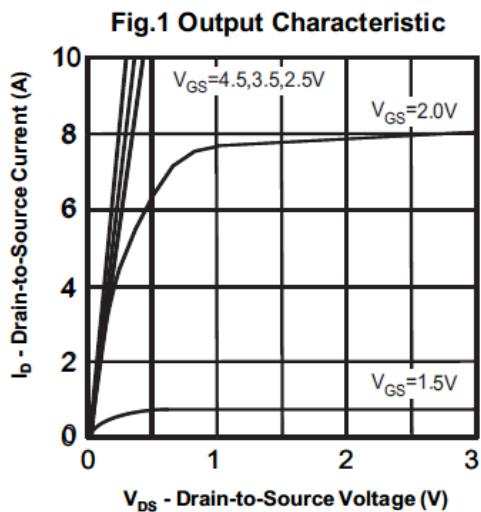
◆ Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
• Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm 8\text{V}, V_{DS}=0\text{V}$	-	-	± 100	nA
• On Characteristics						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.6	0.8	1.2	V
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	$V_{GS}=4.5\text{V}, I_D=2.8\text{A}$	-	40	60	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=2\text{A}$	-	50	115	
		$V_{GS}=1.8\text{V}, I_D=2\text{A}$	-	80	130	
• Dynamic Characteristics^d						
C_{iss}	Input Capacitance	$V_{DS}=10\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	-	456.41	-	pF
C_{oss}	Output Capacitance		-	86.81	-	
C_{rss}	Reverse Transfer Capacitance		-	58.89	-	
• Switching Characteristics^d						
Q_g	Total Gate Charge	$V_{DS}=10\text{V}, I_D=3.6\text{A}, V_{GS}=4.5\text{V}$	-	4.5	-	nC
Q_{gs}	Gate-Source Charge		-	0.83	-	
Q_{gd}	Gate-Drain Charge		-	1.18	-	
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=15\text{V}, R_L=5.5\Omega, I_D=1\text{A}, V_{GEN}=4.5\text{V}, R_G=6\Omega$	-	11.24	-	nS
t_r	Turn-on Rise Time		-	3.48	-	
$t_{d(off)}$	Turn-off Delay Time		-	19.64	-	
t_f	Turn-off Fall Time		-	4.4	-	
• Drain-Source Diode Characteristics						
I_s	Maximum Diode Forward Current	$V_{GS}=0\text{V}, I_s=1.6\text{A}$	-	-	1.6	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS}=0\text{V}, I_s=1.6\text{A}$	-	-	1.2	V

Note: Pulse Test: Pulse Width $\leq 300\text{us}$, Duty Cycle $\leq 2\%$

d: Guaranteed by design: not subject to production testing

◆ Characteristics Curve



◆ Characteristics Curve

Fig. 7 Gate Charge Waveform

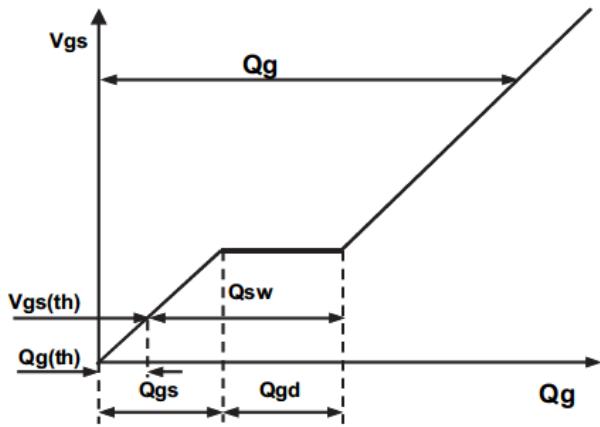


Fig. 8 Gate Charge

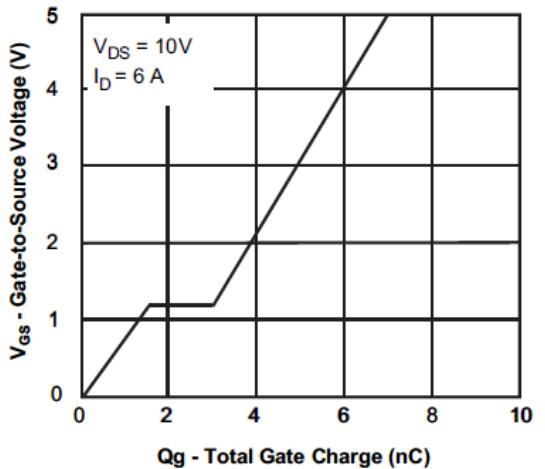


Fig. 9 Maximum Safe Operating Area

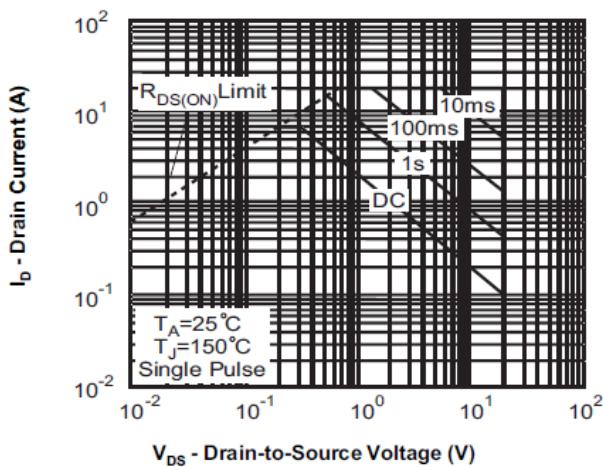
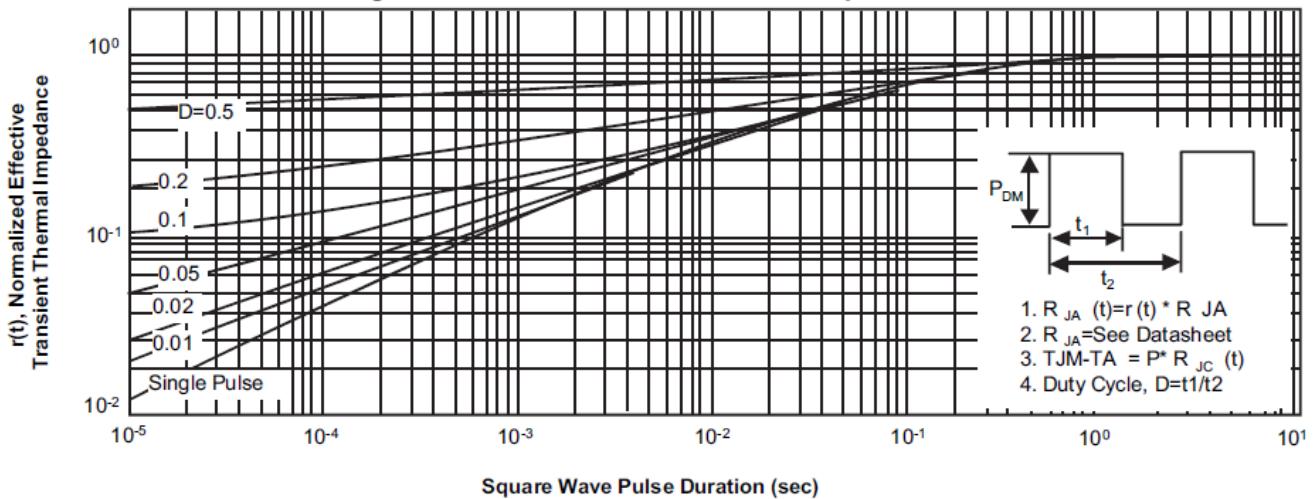


Fig. 10 Normalized Thermal Transient Impedance Curve



◆ Characteristics Curve

